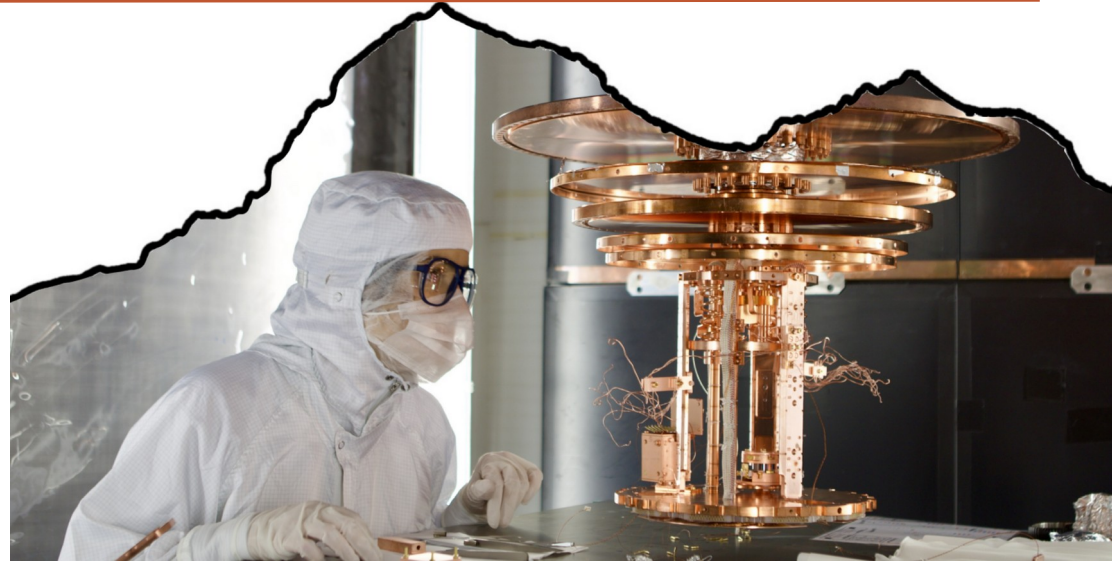


Direct Dark Matter Search with the CRESST III Experiment

Status and Prospects

Scientific Committee Meeting
October 3, 2024

Anna Bertolini
Max-Planck-Institute for Physics
on behalf of the CRESST collaboration



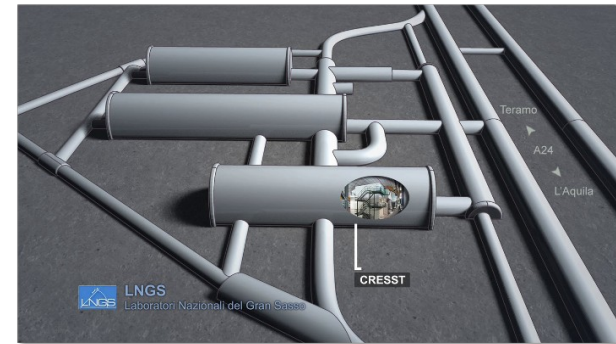
The CRESST Collaboration



~60 members
9 institutions
5 countries

Cryogenic Rare Event Search with Superconducting Thermometers

Located in hall A



COMENIUS
UNIVERSITY
BRATISLAVA



UNIVERSITÄT
HEIDELBERG
ZUKUNFT
SEIT 1386



Istituto Nazionale di Fisica Nucleare
Laboratori Nazionali del Gran Sasso



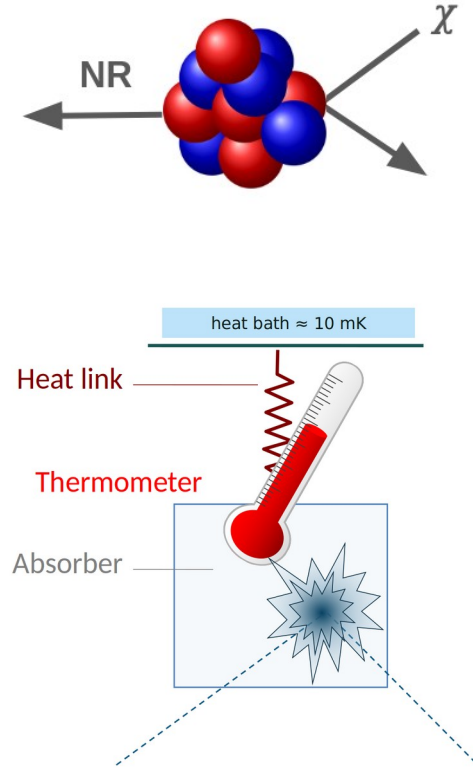
EBERHARD KARLS
UNIVERSITÄT
TÜBINGEN



The CRESST Experiment

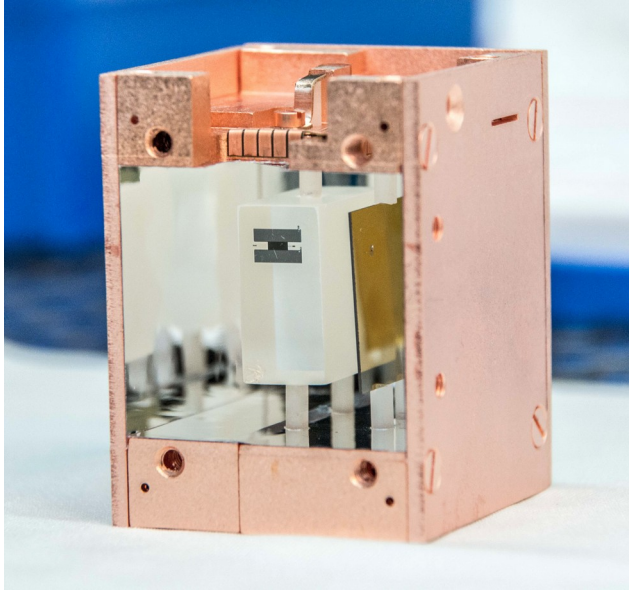


- Detects potential DM particles via scattering off nuclei
- A particle interaction causes an energy deposition in the crystal
→ $\Delta T = \Delta E/C$
- Temperature measurement via Transition Edge Sensor (TES)



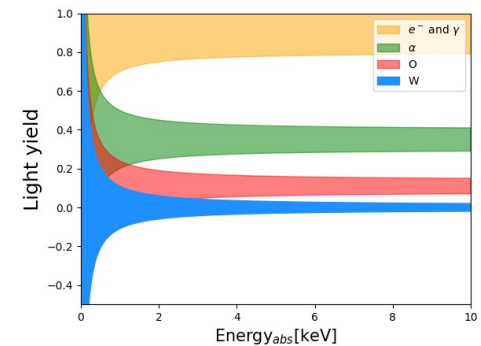
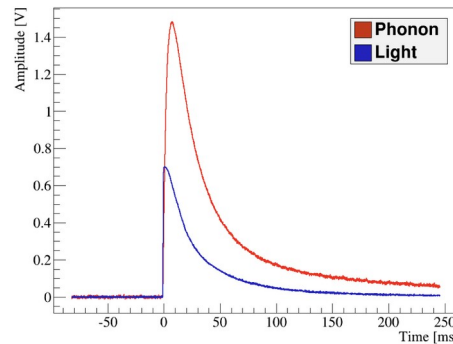
CRESST III Detectors

Aimed at detecting sub-GeV DM



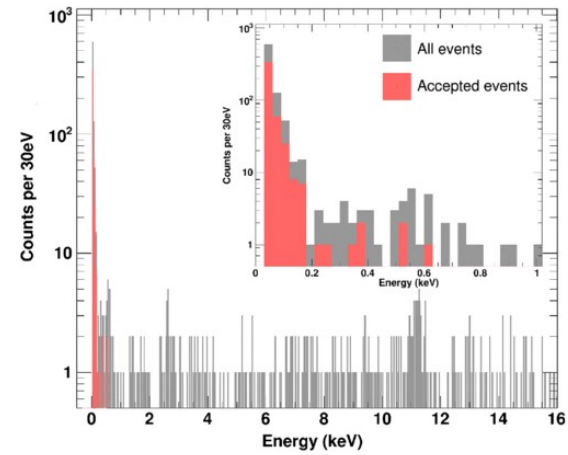
Standard Detector:

- Scintillating CaWO₄ crystal as main absorber (2x2x1) cm³
- Additional light detector for active background discrimination
- Simultaneous readout of phonon and light channels



Reaching Low Energies

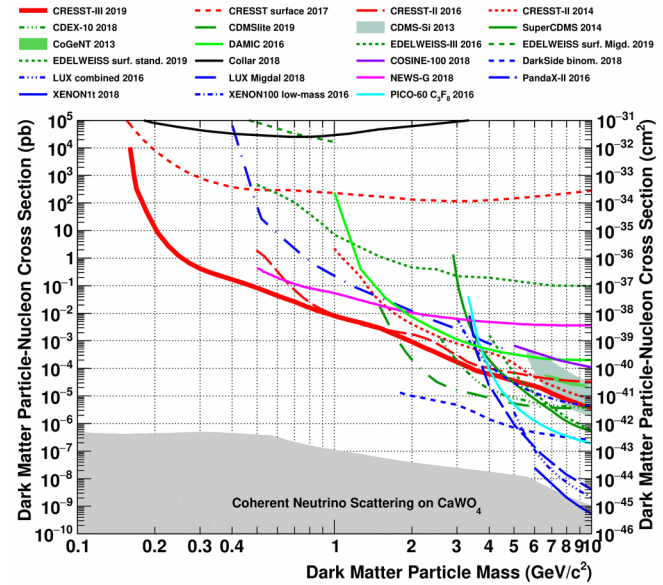
- Thanks to the CRESST III detector design we reached a nuclear recoil energy threshold of **30.1 eV**



We observed an excess of events of unknown origin “Low Energy Excess” (LEE)

- Following run → dedicated **modifications** to the standard CRESST III detector design → probe possible LEE origins

Phys. Rev. D 100, 102002



Sensitivity limited by LEE

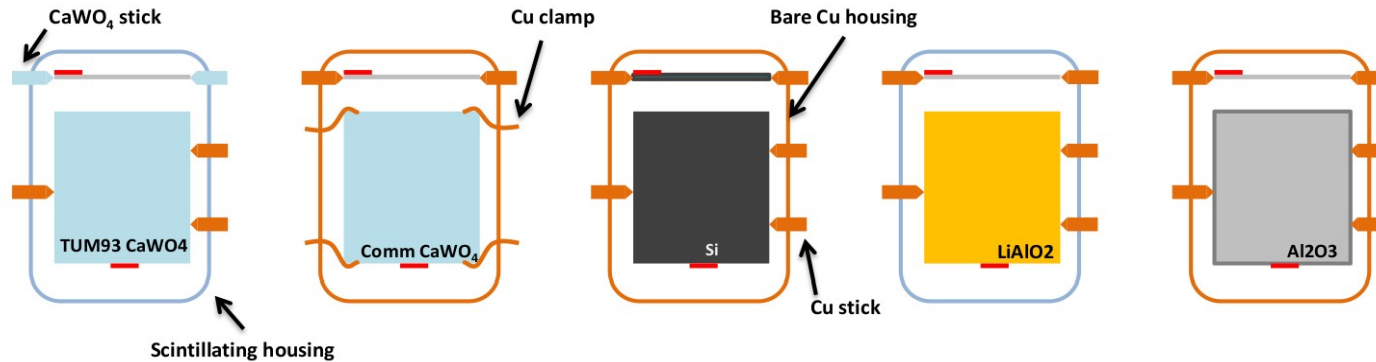
Possible Origins of the LEE

Related to target material?

Depending on crystal growth parameters?

Related to scintillating materials?

Dedicated modifications:



Caused by holder?

Depending on detector geometry?

Possible Origins of the LEE

Related to target material?

Tested several materials

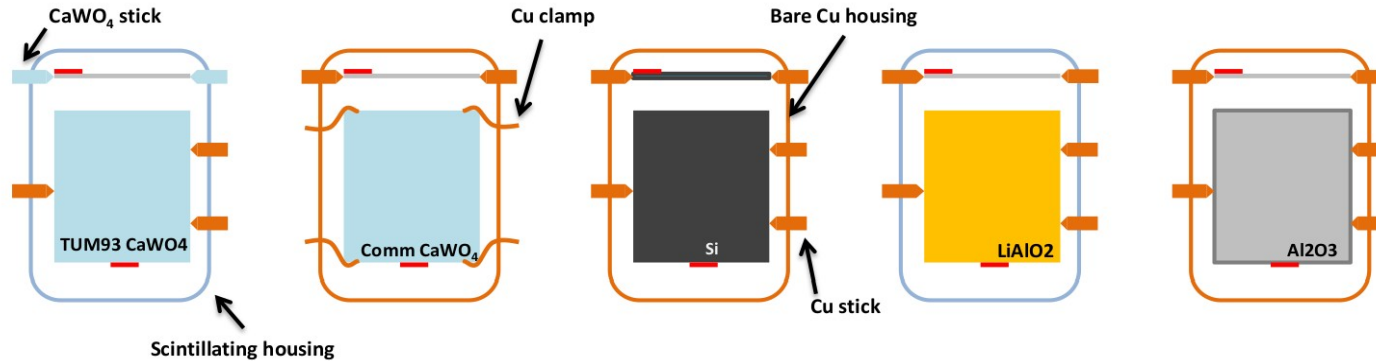
Depending on crystal growth parameters?

Tested slow grown crystal

Related to scintillating materials?

Removed scintillating materials

Dedicated modifications:



Adopted different holding mechanisms

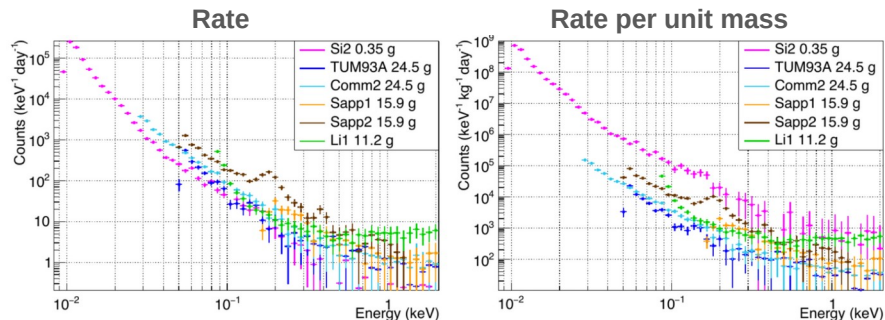
Analyzed LEE in a wafer detector

Caused by holder?

Depending on detector geometry?

LEE Energy Spectrum

arXiv:220709375v2



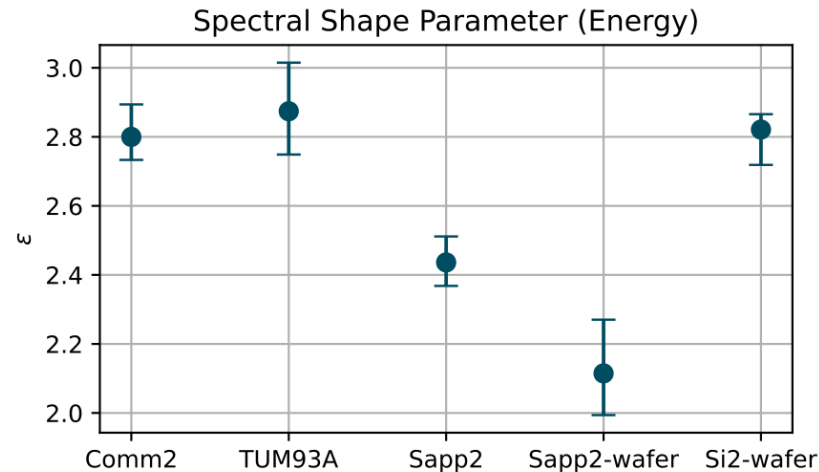
The LEE is observed in every material and geometry

Rate does not scale with mass

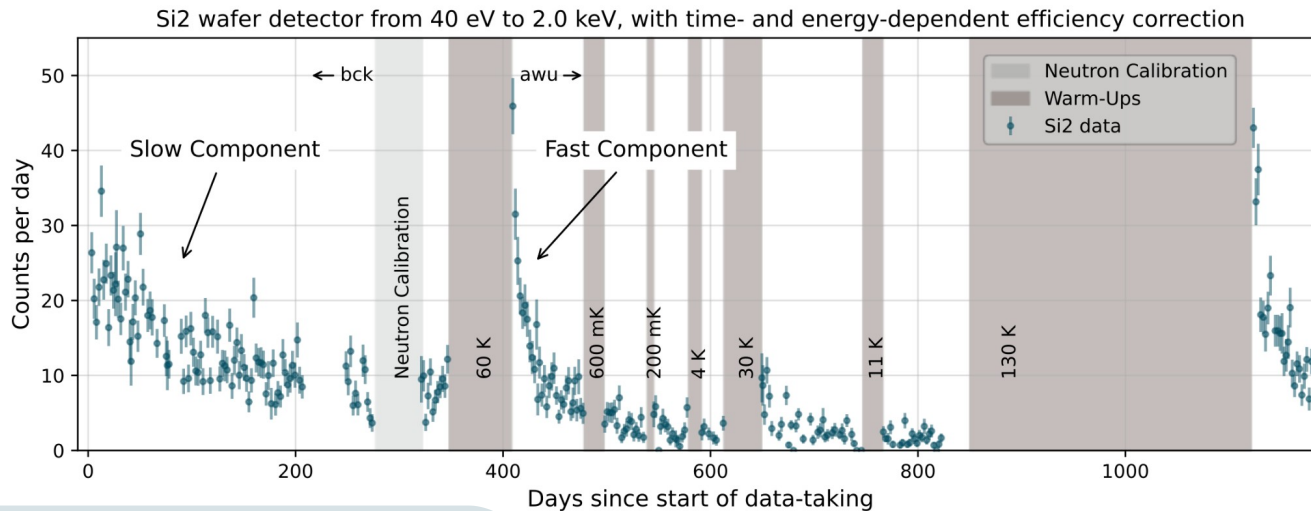
None of the modifications had a significant impact on the LEE

The spectral shape is well described by a power-law

$$N(E, t) = C + E^{-\varepsilon}$$

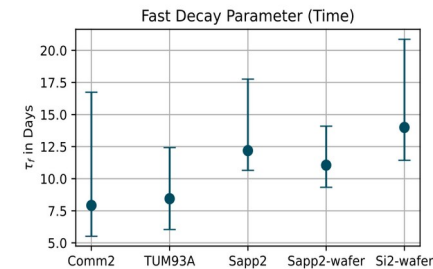
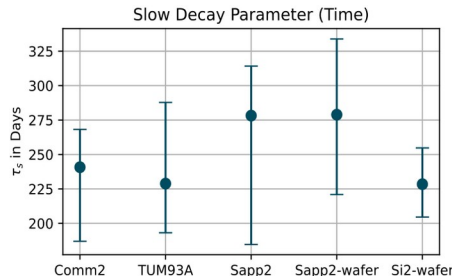


LEE Time Dependence



Rate monitoring over time:

- Rate decays exponentially in time
- Reset of the rate after warm-up cycles
- Two decay constants
 - Fast decay ~ 10 days
 - Slow decay ~ 250 days



Summary LEE

What we learned about the LEE:

- Rate decays over time and resets after warm-up
→ excludes radioactive origin
- Observations are compatible with LEE rate **not** dependent on
 - Material/growth parameters
 - Mass
 - Scintillating materials
 - Detector geometry
 - Holding method

Possible origins to test:

- Holding induced stress
- Interface crystal-TES



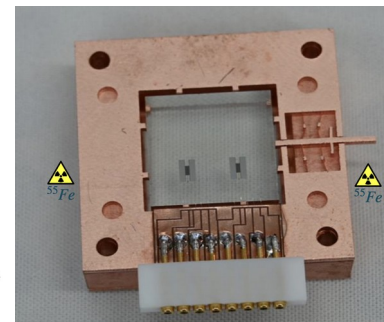
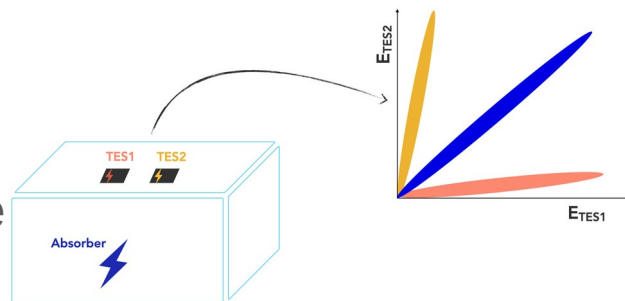
Development of new
detector designs

DoubleTES Module

Idea:

Instrument the crystal with two TESs

- Events in absorber
→ two TESs show same response
- Events in/close to the sensor
→ response is different

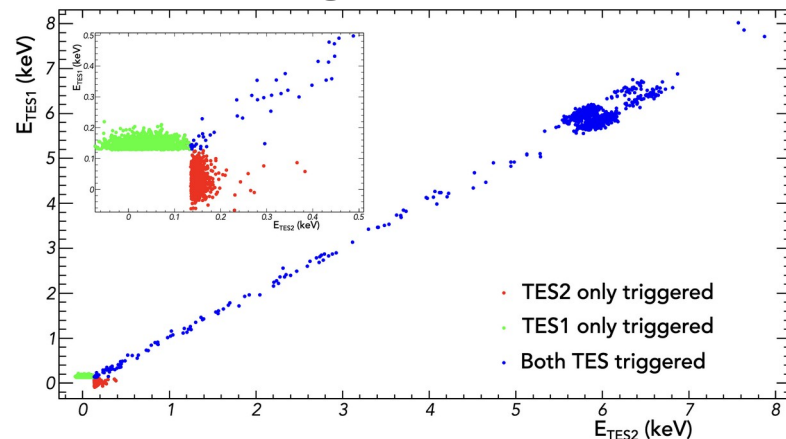


We can probe origin of LEE in:

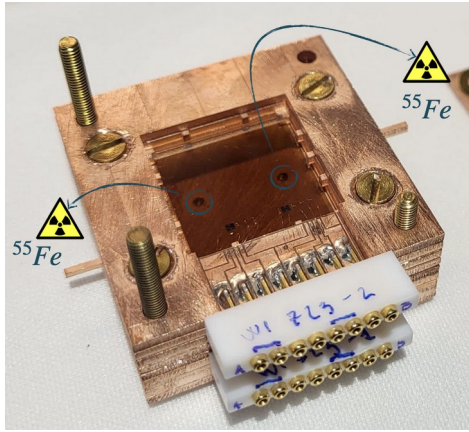
- TES induced events
- Interface between crystal and sensor

Test above ground

arXiv 240402607
EPJC final review



DoubleTES Module



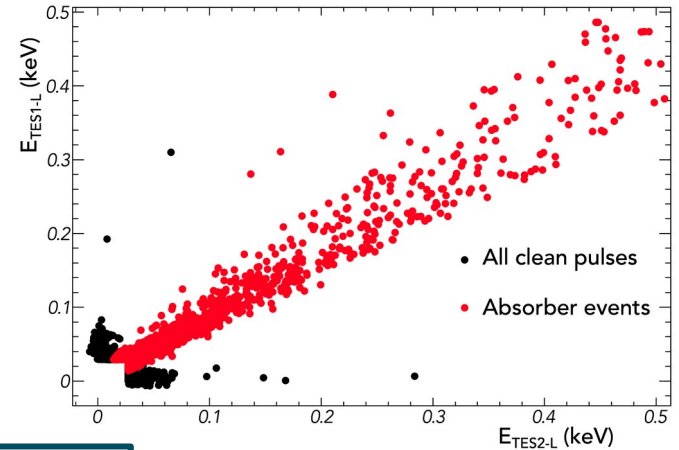
Second measurement:
Double TES on sapphire wafer to access lower thresholds
→ Better study of LEE

Conclusion from both above ground measurements:

- There are multiple components to the excess
- Single TES events are one component of the excess

Test above ground

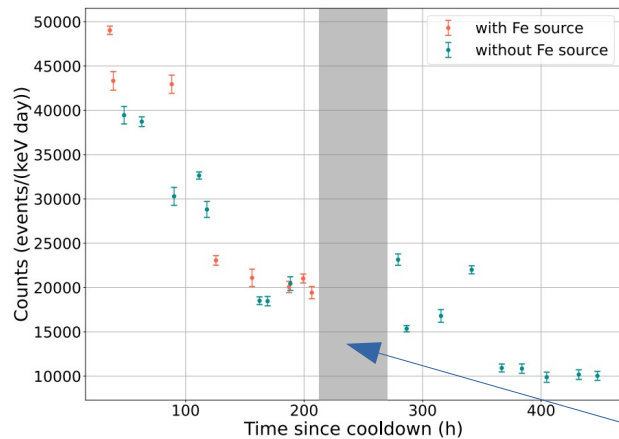
arXiv 240402607
EPJC final review



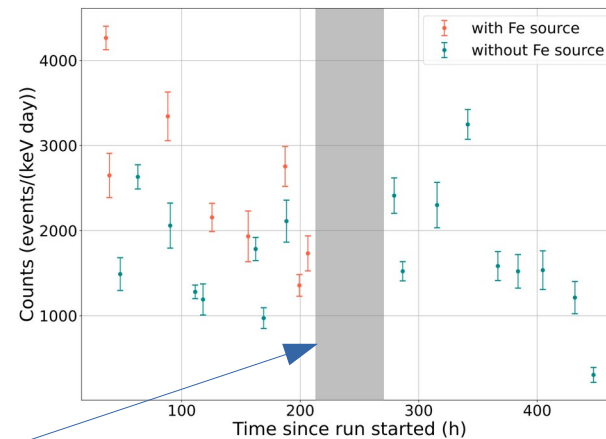
DoubleTES - Time Dependence

- **Absorber** component of the LEE decays with a time constant of ~ 10 days
- No clear decay observed for the **single TES** components in the limited time frame (~ 450 h)

Absorber events



Single-TES events

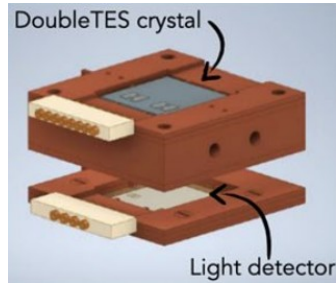


Installation of
additional
radiation shield

Run37 Detectors

Mounted in recently started Run37:

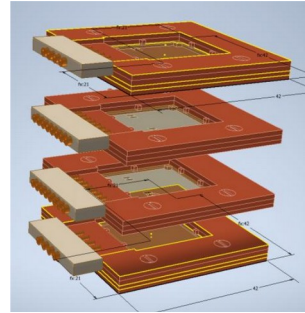
DoubleTES



- CaWO_4 crystal 20x20x10 mm³
- Operated with two TESs
- Gravity assisted holder
- Light detector (Silicon-On-Sapphire wafer)

sensitive to sensor events +
exposure

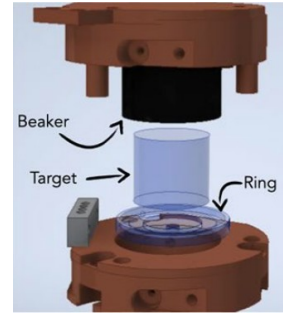
DoubleTES-Stack



- 4 Silicon-On-Sapphire wafers
20x20x0.4 mm³
- All operated with two TESs
- Gravity assisted holder

sensitive to sensor events + low
thresholds + surface veto

Mini Beaker



- Sapphire cylindrical crystal
→ 4 cm³
- Connected to a sapphire ring
→ identification of events
transmitted by holder
- Silicon beaker

4 π veto

+ 1 standard CRESST-III module from Run36 as reference

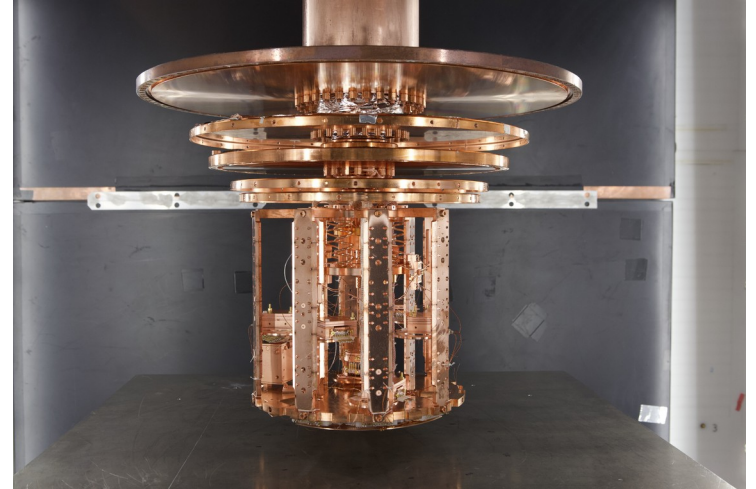
Current Status

New run started in April 2024

- Several double TES running
- Optimization done
- Calibration ongoing

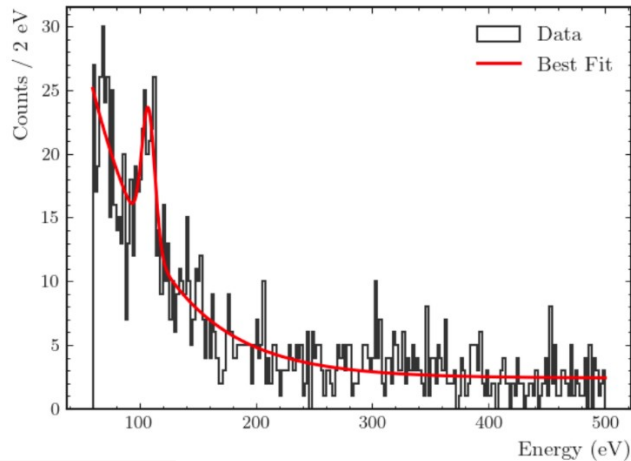
Detectors:

- 5 double TES + light detector
 - Total 15 channels
 - only 2 TES not operated
- 1 light detector stack
 - composed of 4 light detectors → 8 channels all working
- 1 Mini beaker → 3 channels all working
- 1 Detector unchanged from Run36 as reference → 2 channels all working

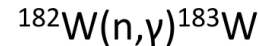


Double TES

- Double TES modules are not calibrated with an iron source inside the module (like previous run)
- Calibration via neutron capture peak (feasibility shown in previous run)
- Neutron calibration - data taking ongoing



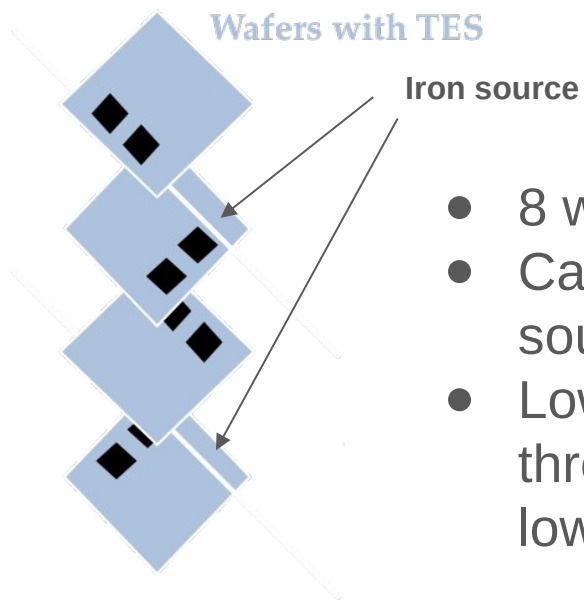
Energy calibration for nuclear recoil



de-excitation with a single γ (6.1MeV)

↳ mono-energetic nuclear recoil 112.4eV

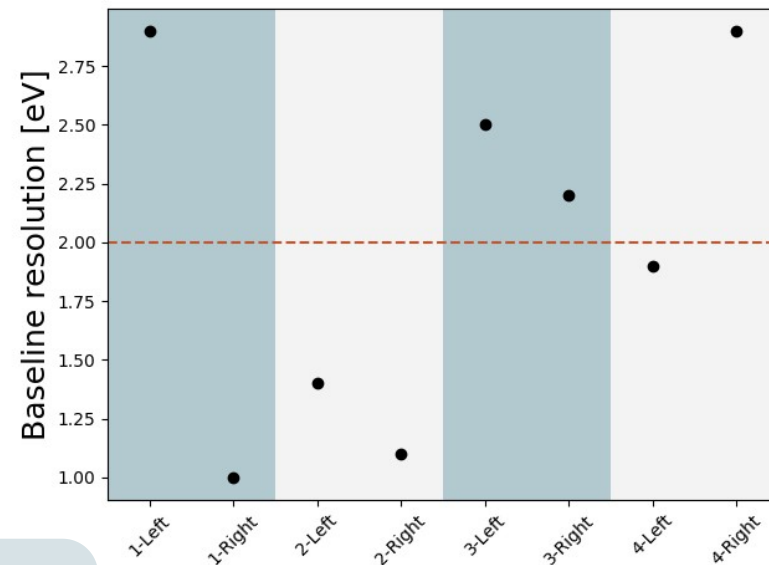
Light Detector Stack



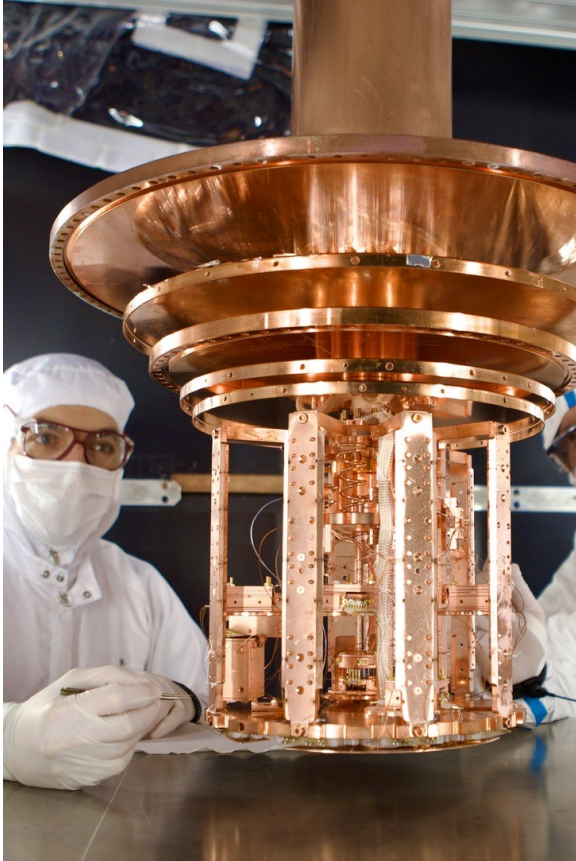
- 8 working channels
- Calibrated with ^{55}Fe source
- Low energy thresholds thanks to low mass targets

All channels of the channels have a baseline resolution below 3eV (threshold below $\sim 15\text{eV}$)

Preliminary



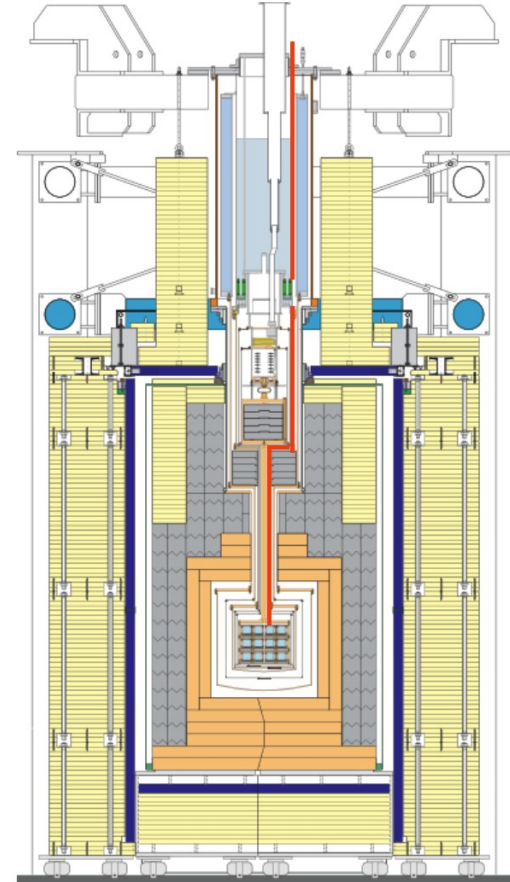
Next Steps



- Complete neutron calibration (fall 2024)
- Start background data taking (fall 2024)
- First Double TES data expected by spring 2025
- End of experimental Run37 in summer 2025 (when the He liquefier will be discontinued for upgrade)*

* Could be revised if the LEE reduction allows relevant sensitivity improvement

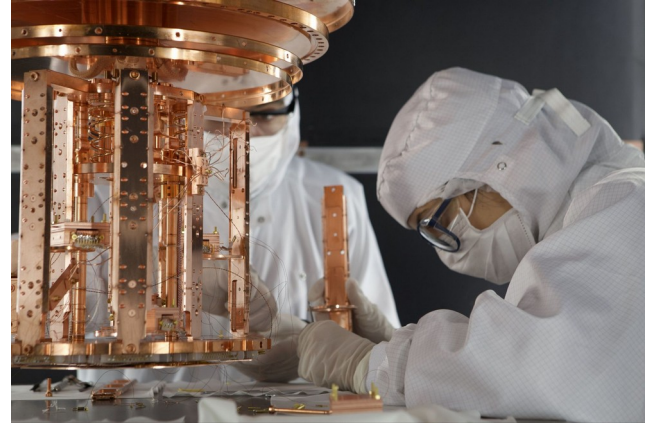
Readout Renewal



- Over the years, significant aging of the readout chain reduced the number of useable channels
 - reduces the test capabilities
 - limits reachable exposure
- New readout chain (288 channels) already funded by agencies and almost completely procured
- New readout electronics being produced
- Installation planned after the end of Run37 aligned with the stop of the He production plant

Summary

- CRESST is making continuous progress in understand the LEE
- New run ongoing
- Several double TES running
- Calibration ongoing
- Results coming soon

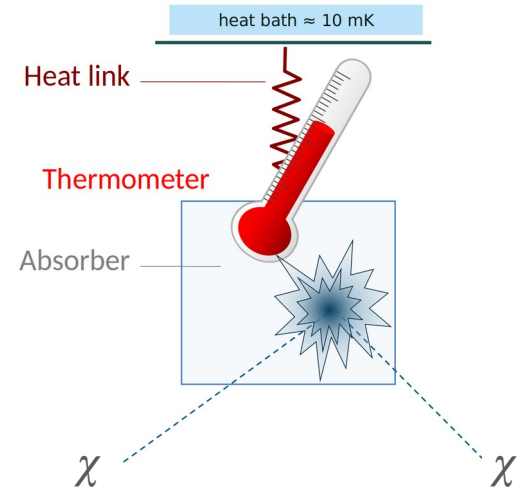


Stay tuned!

BACKUP

Cryogenic Calorimeters

- Basic setup: crystal equipped with temperature sensor
- A particle interaction causes an energy deposition in the crystal
- Calorimeter equation: $\Delta T = \Delta E / C$

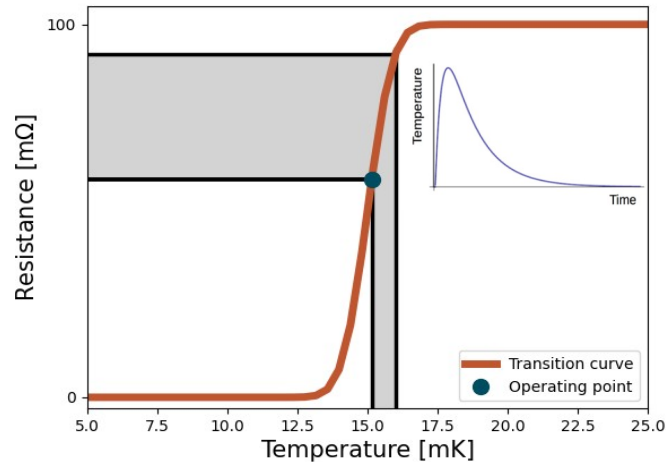


For low heat capacity (true at low temperatures)

⇒ low energy deposition can lead to significant temperature variation

- Read out by Transition Edge Sensor (**TES**)

The Transition Edge Sensor



Energy deposition in absorber \sim keV



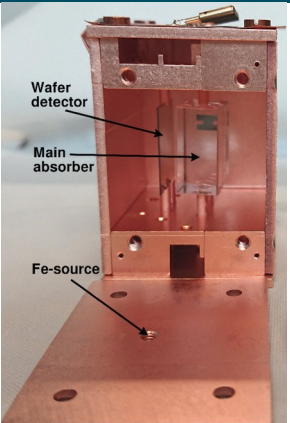
Temperature rise in TES \sim μ K



Resistance change \sim m Ω

- Sensor is operated at the transition between normal- and superconducting phase
- Very small temperature variations can be read out through measurable changes in the resistance

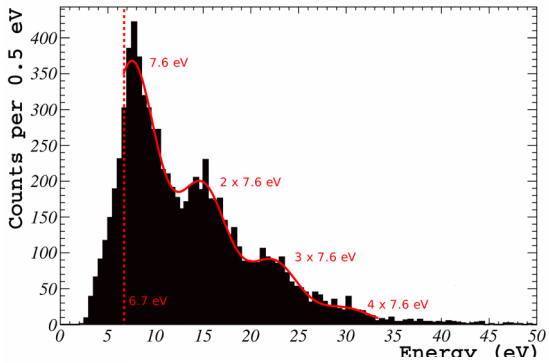
New Calibration: Sapphire VUV Luminescence



New calibration:
 vacuum ultraviolet (VUV)
 luminescence @7.6 eV from the
 nearby sapphire crystal is
 observed in the wafer

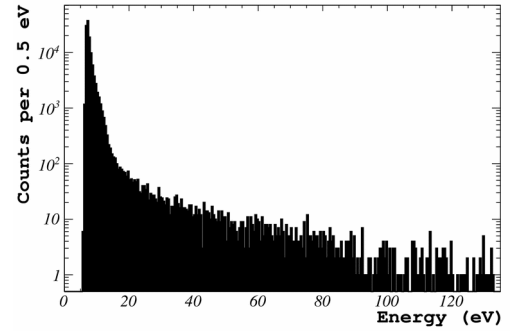
arXiv:2405.06527

Iron events

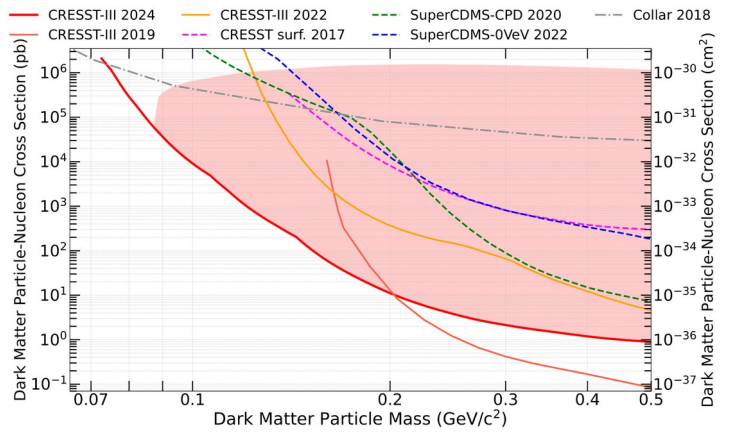


Single
 photon
 detection
 @N x 7.6 eV

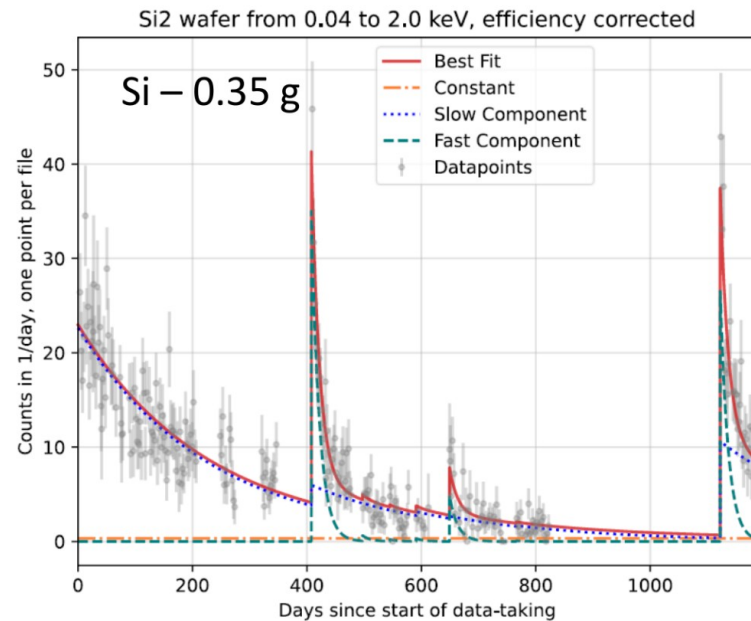
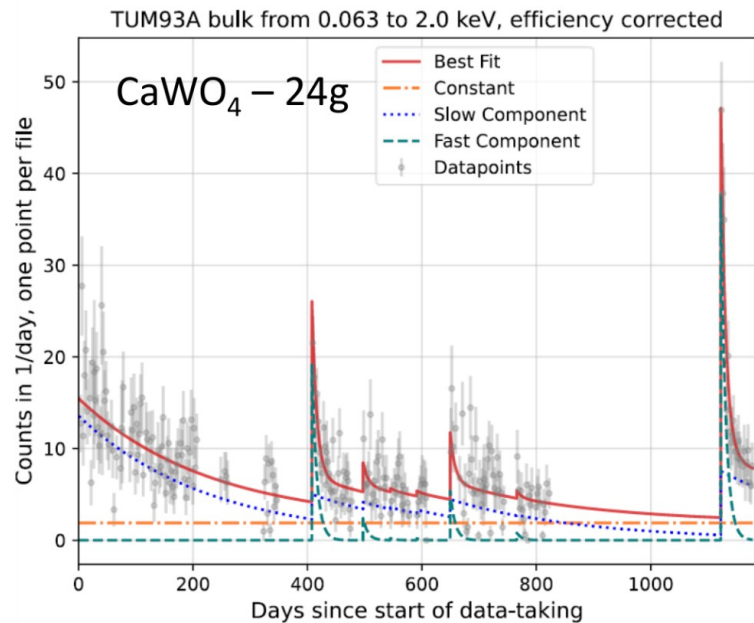
Calibrated spectrum



Spin-Independent
 exclusion limits
 → probe new
 parameter space

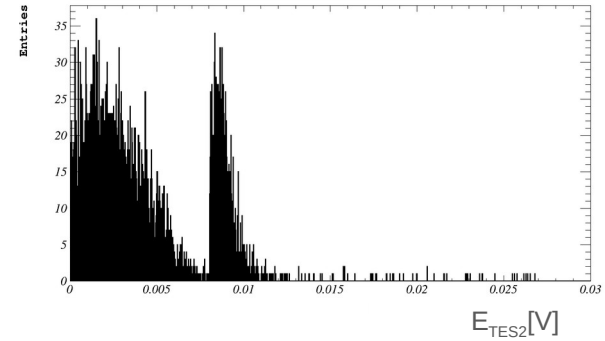
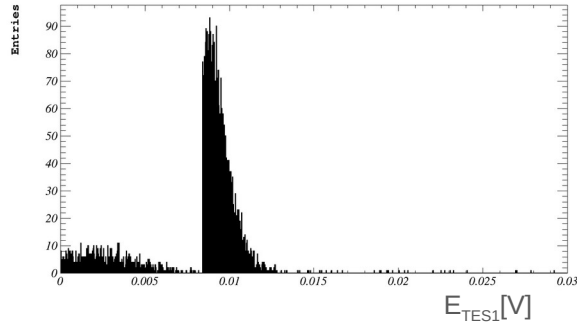


LEE Components

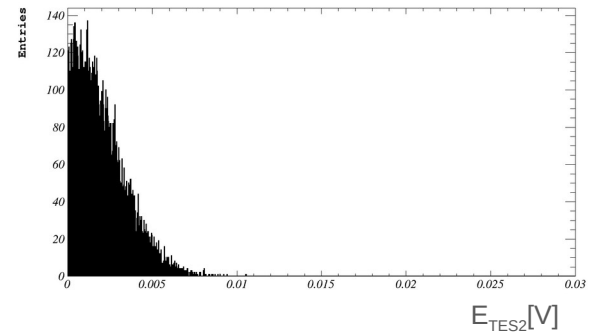
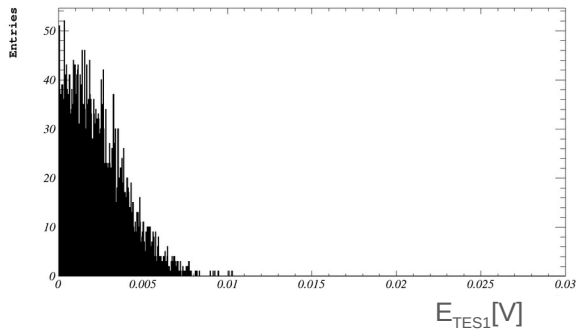


Double TES - Noise Study

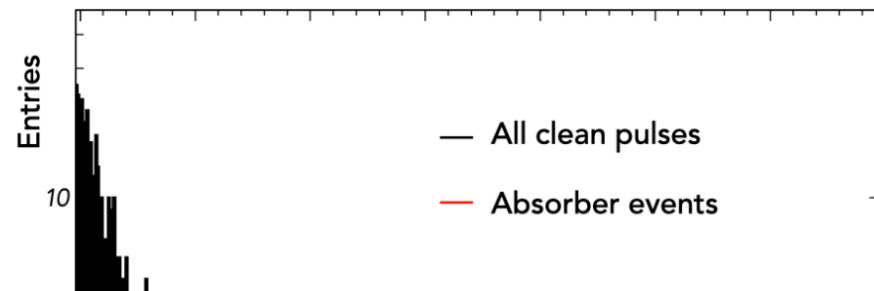
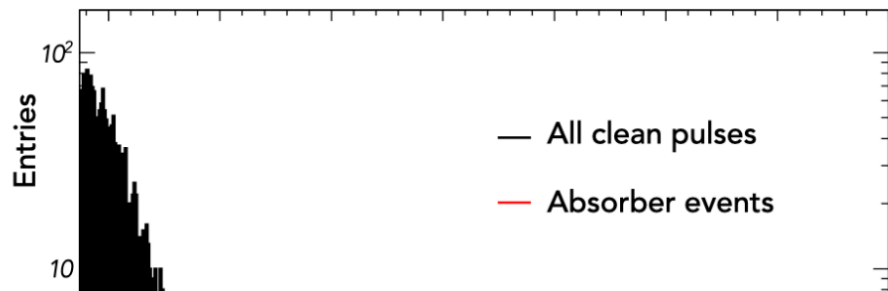
Non-calibrated spectra below threshold:



Inverted stream data (positive-negative) - non-calibrated noise spectra:



Double TES - Calibrated Spectra



Single TES events contribute to the LEE